

Search Notes

Application/Control No.

09/274,157

Examiner

Richard Lee

Applicant(s)/Patent under
Reexamination

MCVEIGH ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	7/20/2006	RL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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